

Search Notes

Application/Control No.

10/696,175

Examiner

Jason M. Han

Applicant(s)/Patent under
Reexamination

AYNIE ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	511	5/16/2005	JMH
362	518	5/16/2005	JMH
362	522	5/16/2005	JMH
362	540	5/16/2005	JMH
362	327	5/16/2005	JMH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
362	511	5/16/2005	JMH
362	518	5/16/2005	JMH
362	522	5/16/2005	JMH
362/540, 327		5/16/2005	JMH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update	5/16/2005	JMH
P.E. Stephen Husar	5/16/2005	JMH